

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination BASEMAN ET AL.	
		Examiner Paul D. Kim	Art Unit 3729	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,872,997	03-2005	Liu et al.	257/295
*	B	US-5,569,617	10-1996	Yeh et al.	438/3
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Dual layer overcoat for MR recording media"; Ga-Lane Chen; Junhoa Wu; Weiss, J.; Magnetics, IEEE Transactions on Volume 35, Issue 5, Part 1; Sept. 1999; Pages:2364 - 2366.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.